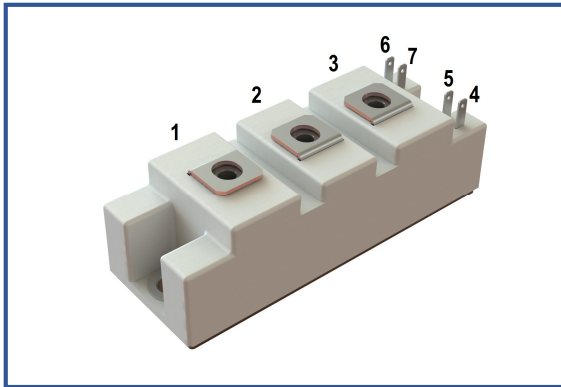


## Industry standart 34mm IGBT module

1200 V 150 A


**Chip features**

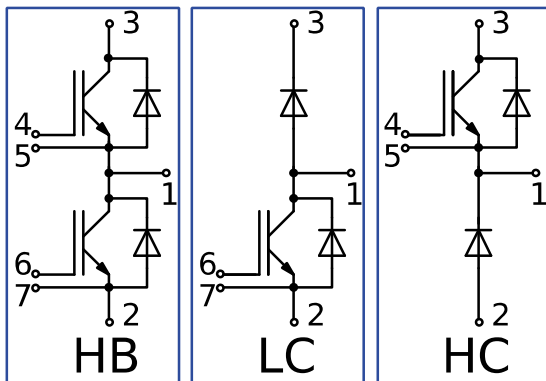
- IGBT chip
  - Trench FS — V-Series IGBT ( 6<sup>th</sup> gen)
  - low  $V_{CE(sat)}$  value
  - 10  $\mu$ s short circuit of 150°C
  - square RBSOA of 2xI<sub>C</sub>
  - low EMI
- FRD chip
  - fast and soft reverse recovery
  - low voltage drop

**Design features**

- copper baseplate
- Al<sub>2</sub>O<sub>3</sub> DBC substrate
- ultrasonically welded power terminals
- Improved thermal cycling
- RoHS compliant

**Typical application**

- AC motor drivers
- solar inverter
- air conditioning
- high power converters and UPS


**Maximum rated values**

Definition	Symbol	Conditions	Value	Unit
<b>IGBT</b>				
Collector-Emitter voltage	$V_{CES}$	$V_{GE} = 0$ .	1200	V
Collector current (nominal)	$I_{C\ nom}$		150	A
Collector current (maximum continuous)	$I_{C\ 25}$	$T_{vj\ (max)} = 175^{\circ}C$ ; $T_c = 25^{\circ}C$ .	232	A
	$I_{C\ 80}$	$T_{vj\ (max)} = 175^{\circ}C$ ; $T_c = 80^{\circ}C$ .	179	A
Repetitive peak collector current* <sup>1</sup>	$I_{CRM}$	$I_{CRM} = 3 \times I_{C\ nom}$ ; $t_p = 1\ ms$ .	450	A
Short-circuit duration	$t_{psc}$	$T_{vj} = 25^{\circ}C$ ; $V_{GE} = \pm 15\ V$ ; $V_{CE} = 700\ V$ ; $R_{G\ on} = R_{G\ off} = 1.5\ \Omega$ ; $I_{C\ max} < 1100\ A$ .	10	$\mu$ s
		$T_{vj} = 150^{\circ}C$ ; $V_{GE} = \pm 15\ V$ ; $V_{CE} = 700\ V$ ; $R_{G\ on} = R_{G\ off} = 1.5\ \Omega$ ; $I_{C\ max} < 1100\ A$ .	10	
Gate-Emitter voltage	$V_{GES}$		$\pm 20$	V
Junction operating temperature	$T_{vj\ (op)}$		-40...+150	°C
<b>Inverse diode \ Freewheeling diode</b>				
Repetitive peak reverse voltage	$V_{RRM}$	$V_{GE} = 0\ V$ .	1200	V
Forward current (nominal)	$I_{F\ nom}$		150	A
Forward current (maximum continuous)	$I_{F\ 25}$	$T_{vj\ (max)} = 175^{\circ}C$ ; $T_c = 25^{\circ}C$ .	220	A
	$I_{F\ 80}$	$T_{vj\ (max)} = 175^{\circ}C$ ; $T_c = 80^{\circ}C$ .	146	A
Repetitive peak forward current* <sup>1</sup>	$I_{FRM}$	$I_{FRM} = 3 \times I_{F\ nom}$ ; $t_p = 1\ ms$ .	450	A
Junction operating temperature	$T_{vj\ (op)}$		-40...+150	°C
<b>Module</b>				
Storage temperature	$T_{stg}$		-40...+50	°C
Isolation voltage	$V_{isol}$	AC sin 50 Hz; t = 1 min.	4000	V

\*1 Pulse width and repetition rate should be such that device junction temperature does not exceed maximum  $T_{vj}$  rating

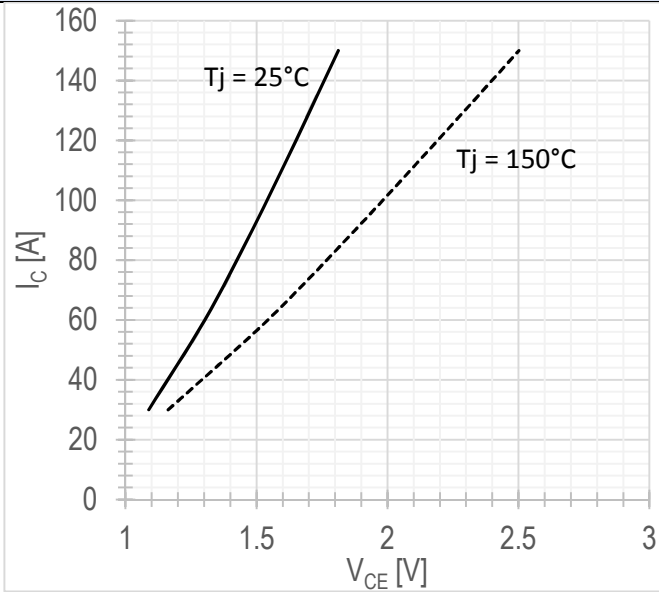
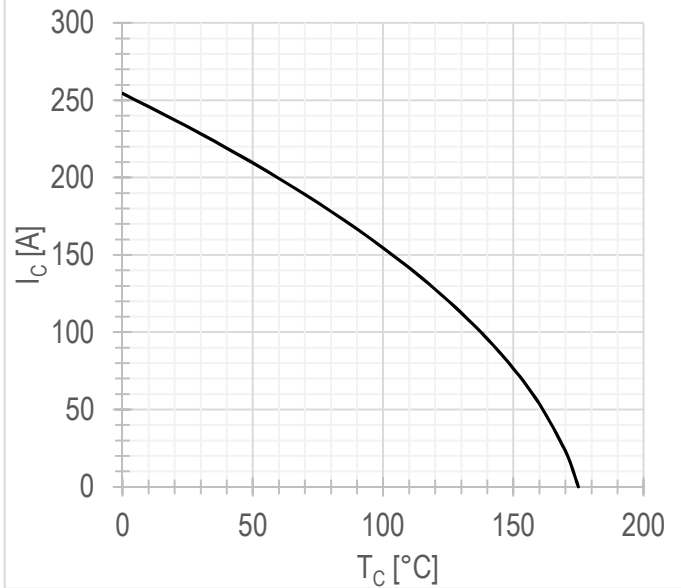
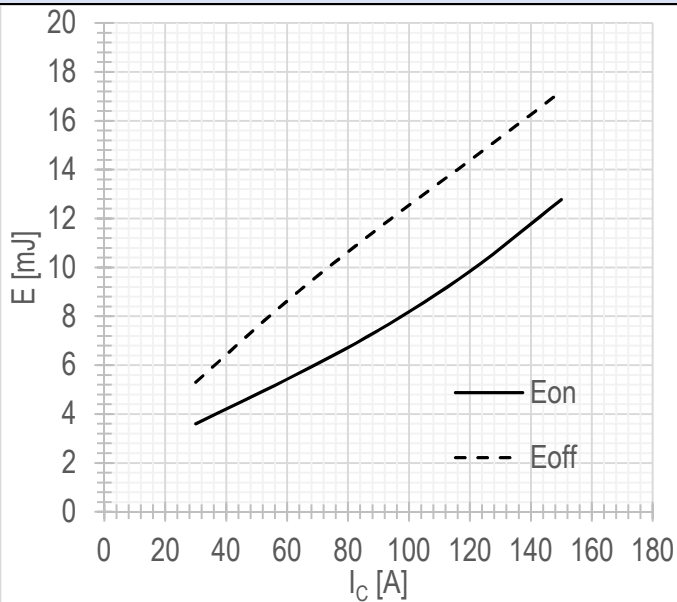
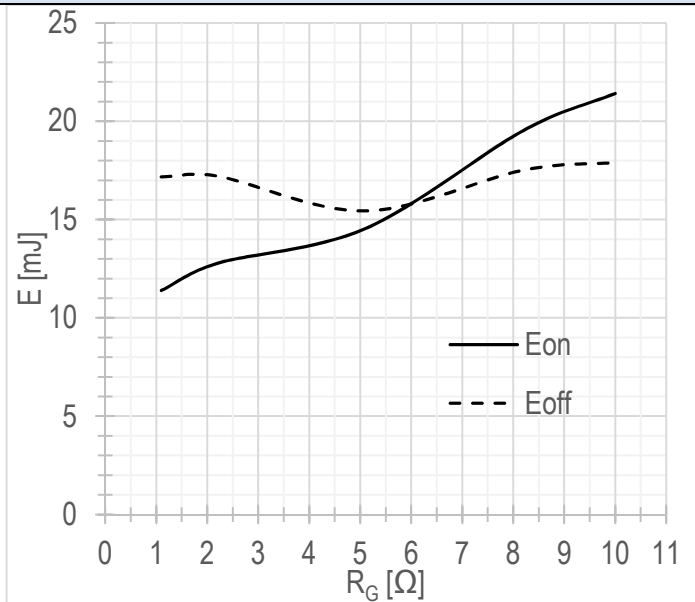
**Characteristics**

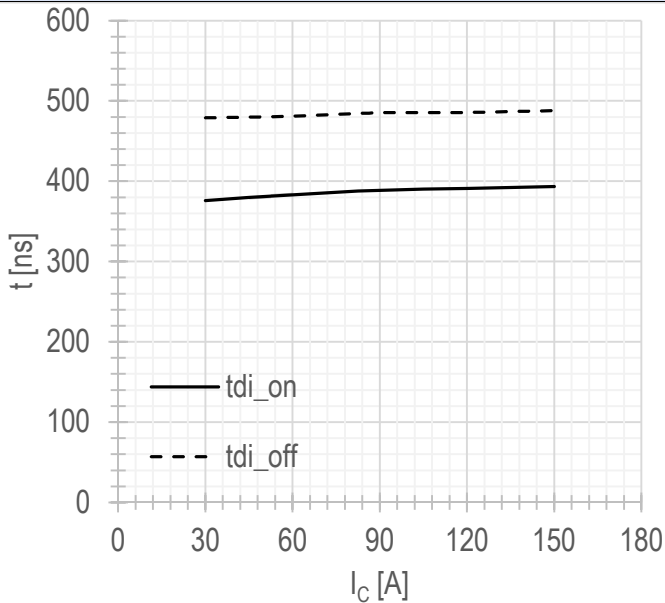
Definition	Symbol	Conditions	Value			Unit		
			min.	typ.	max.			
<b>IGBT</b>								
Collector-Emitter saturation voltage	$V_{CEsat}$	$V_{GE} = +15\text{ V}; I_C = 150\text{ A};$ $t_u = 1000\ \mu\text{s}.$	$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	1.77 2.26	1.81 2.31	1.90 2.50	V V	
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C = 1.6\text{ mA}; V_{CE} = V_{GE}; T_{vj} = 25^\circ\text{C};$ $t_u = 2\text{ ms}.$		5.50	6.04	6.50	V	
Collector-Emitter cut-off current	$I_{CES}$	$V_{CE} = 1200\text{ V};$ $t_u = 10\text{ ms}; V_{GE} = 0.$	$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	2.32 0.77	2.71 0.98	150 1.50	$\mu\text{A}$ mA	
Gate-Emitter leakage current	$I_{GES}$	$V_{CE} = 0; V_{GE} = \pm 20\text{ V}; T_{vj} = 25^\circ\text{C};$ $t_u = 30\text{ ms}.$		10.0	13.9	125	nA	
Input capacitance	$C_{ies}$	$V_{CE} = 10\text{ V}; V_{GE} = 0\text{ V};$ $f = 1\text{ MHz}; T_{vj} = 25^\circ\text{C}.$		-	13.8	-	nF	
Output capacitance	$C_{oes}$			-	1.00	-	nF	
Reverse transfer capacitance	$C_{res}$			-	1.20	-	nF	
Total gate charge	$Q_G$	$I_C = 150\text{ A}; V_{CE} = 600\text{ V};$ $V_{GE} = -8 \div 15\text{ V}.$		-	1565	1676	nC	
Internal gate resistance	$R_{Gint}$	$T_{vj} = 25^\circ\text{C}.$		-	5.00	-	$\Omega$	
Turn-on delay time	$t_{d(on)}$	$V_{CE} = 600\text{ V};$ $V_{GE} = \pm 15\text{ V};$ $I_{Cmax} = 150\text{ A};$ $R_G = 1.5\ \Omega;$ $L = 300\ \mu\text{H}.$	$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	331 375	350 390	400 440	ns	
Rise time	$t_{ri}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	46.0 51.0	49.0 53.5	56.0 60.0	ns	
Turn-on energy	$E_{on}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	4.26 10.1	6.30 11.5	8.50 14.0	mJ	
Turn-off delay time	$t_{d(off)}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	407 470	419 483	460 540	ns	
Fall time	$t_{fi}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	183 322	232 354	310 440	ns	
Turn-off energy	$E_{off}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	11.5 15.6	12.5 16.6	16.0 20.0	mJ	
Collector-emitter threshold voltage	$V_{CE0}$		$V_{GE} = +15\text{ V}; T_{vj} = 150^\circ\text{C};$		0.84	0.86	0.90	V
On-State slope resistance (IGBT)	$r_{CE0}$		$I_{CE1} = 38\text{ A}; I_{CE2} = 150\text{ A};$ $t_u = 1000\ \mu\text{s}.$		9.46	9.76	10.7	m $\Omega$
Thermal resistance junction to case	$R_{th(j-c)}$		DC; $I_{CE} = 150\text{ A}; I_{test} = 0.5\text{ A};$ $V_{GE} = +15\text{ V}.$		-	0.146	0.190	K/W
<b>Inverse diode \ Freewheeling diode</b>								
Forward voltage drop	$V_F$	$I_F = 150\text{ A};$ $V_{GE} = 0; t_u = 1000\ \mu\text{s}.$	$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	1.78 1.91	1.83 1.95	1.96 2.10	V V	
Reverse recovery time	$t_{rr}$	$V_{GE} = \pm 15\text{ V};$ $V_{CE} = 600\text{ V};$ $I_{Cmax} = 150\text{ A};$ $L = 300\ \mu\text{H};$ $R_{Gon} = 1.5\ \Omega.$	$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	110 359	122 410	145 500	ns ns	
Repetitive peak reverse current	$I_{rrm}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	127 158	134 167	152 177	A A	
Reverse recovered charge	$Q_{rr}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	9.00 22.2	9.80 23.1	11.0 26.0	$\mu\text{C}$ $\mu\text{C}$	
Reverse recovery energy	$E_{rec}$		$T_{vj} = 25^\circ\text{C}$ $T_{vj} = 150^\circ\text{C}$	4.19 9.61	4.55 10.3	6.00 12.0	mJ mJ	
Threshold voltage	$V_{(T0)}$		$T_{vj} = 150^\circ\text{C}; V_{GE} = 0; I_{CE1} = 38\text{ A};$		0.82	0.83	0.84	V
Forward slope resistance	$r_T$		$I_{CE2} = 150\text{ A}; t_u = 1000\ \mu\text{s}$		7.23	7.53	8.15	m $\Omega$
Thermal resistance junction to case	$R_{th(jc-D)}$	DC; $I_{CE} = 120\text{ A}; I_{test} = 0.5\text{ A};$ $V_{GE} = +15\text{ V}.$		-	0.260	0.320	K/W	

Module							
Pin resistance	$R_{Pxy}$	$T_{vj} = 25^{\circ}\text{C}.$	$R_{P12}$	-	0.47	0.50	mΩ
			$R_{P13}$	-	0.66	0.66	
Parasitic inductance between terminals	$L_{Pxy}$	$T_{vj} = 25^{\circ}\text{C};$ $f = 1 \text{ MHz}.$	$L_{P12}$	-	34.5	35.0	nH
			$L_{P13}$	-	52.3	60.0	
Thermal resistance case to heatsink	$R_{thCH}$	per module		-	0.02	0.04	K/W
Mounting torque for screws to heatsink	$M_s$	to heatsink M6		3.00	-	5.00	Nm
Mounting torque for terminal screws	$M_t$	to terminals M5		2.25	2.50	2.75	Nm
Weight	$W$			-	150	170	g

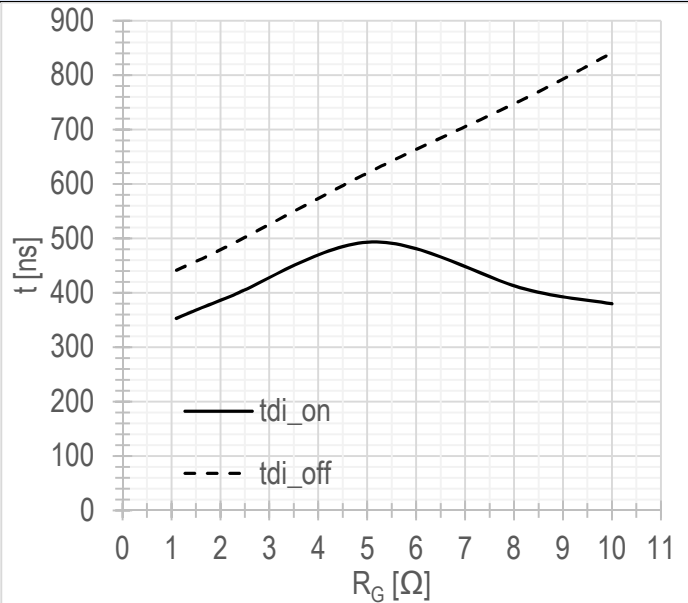
**Notes:**

- Insulating material operating temperature 125°C max;
- Case temperature 125°C max;
- The recommended operating junction temperature  $T_{vj\ op} = -40 \div +150^{\circ}\text{C}.$

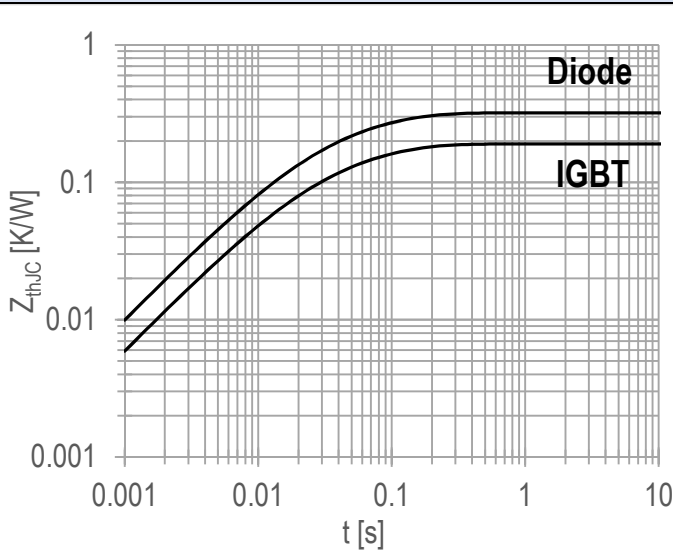
**Chart 1 – typ. output characteristic, IGBT.**

 $V_{GE} = +15 \text{ V.}$ 
**Chart 2 – typ. rated current vs temperature.**

 DC;  
 $V_{GE} = +15 \text{ V;}$   
 $T_{vj(max)} = 150^\circ\text{C.}$ 
**Chart 3 – typ. turn-on/-off energy vs rated current, IGBT.**

 $V_{CE} = 600 \text{ V;}$   
 $V_{GE} = \pm 15 \text{ V;}$   
 $R_G = 1.5 \text{ }\Omega;$   
 $L = 300 \text{ }\mu\text{H;}$   
 $T_{vj(max)} = 150^\circ\text{C.}$ 
**Chart 4 – typ. turn-on/-off energy vs gate resistance, IGBT.**

 $V_{CE} = 600 \text{ V;}$   
 $V_{GE} = \pm 15 \text{ V;}$   
 $I_{Cmax} = 150 \text{ A;}$   
 $L = 300 \text{ }\mu\text{H;}$   
 $T_{vj(max)} = 150^\circ\text{C.}$

**Chart 5 – typ. switching times vs rated current, IGBT.**


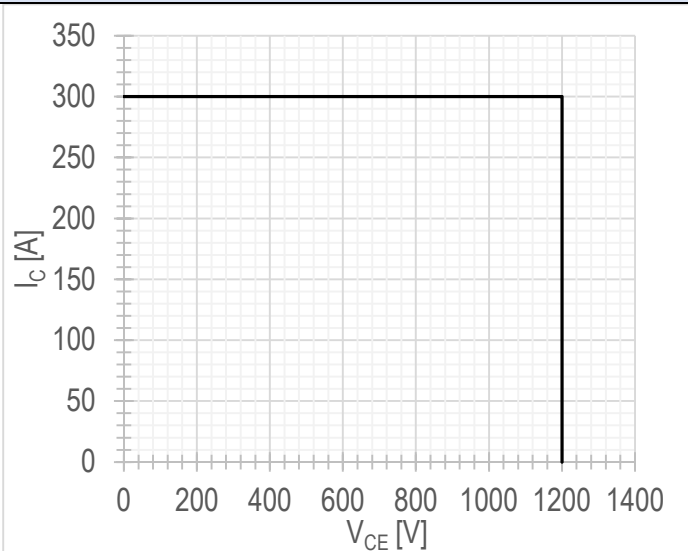
$V_{CE} = 600\text{ V};$   
 $V_{GE} = \pm 15\text{ V};$   
 $R_G = 1.5\ \Omega;$   
 $L = 300\ \mu\text{H};$   
 $T_{vj(max)} = 150^\circ\text{C}.$

**Chart 6 – typ. switching times vs gate resistance, IGBT.**


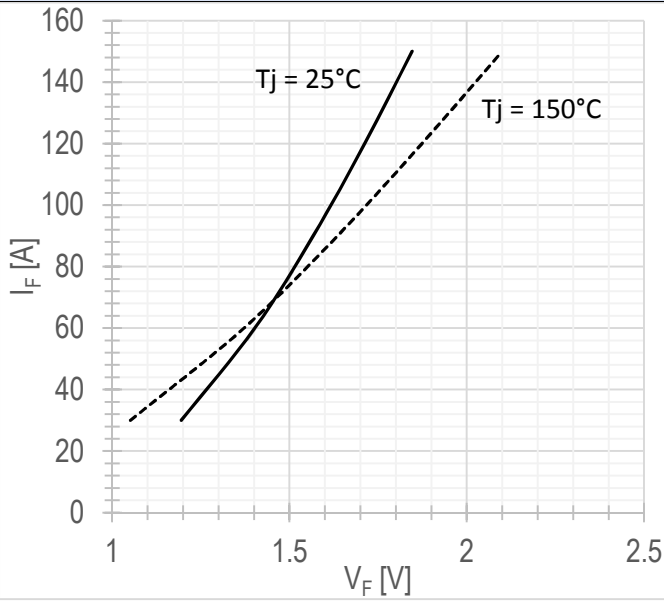
$V_{CE} = 600\text{ V};$   
 $V_{GE} = \pm 15\text{ V};$   
 $I_{Cmax} = 150\text{ A};$   
 $L = 300\ \mu\text{H};$   
 $T_{vj(max)} = 150^\circ\text{C}.$

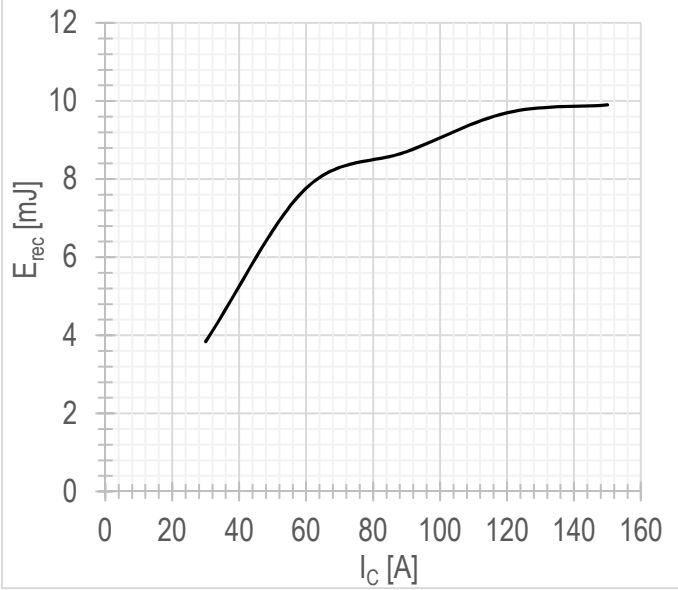
**Chart 7 – max. transient thermal impedance .**


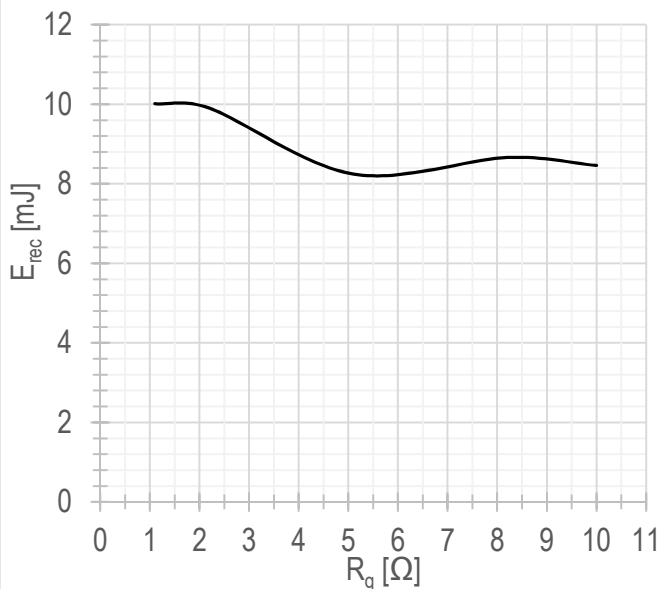
Single pulse;  
 $V_{GE} = +15\text{ V}.$

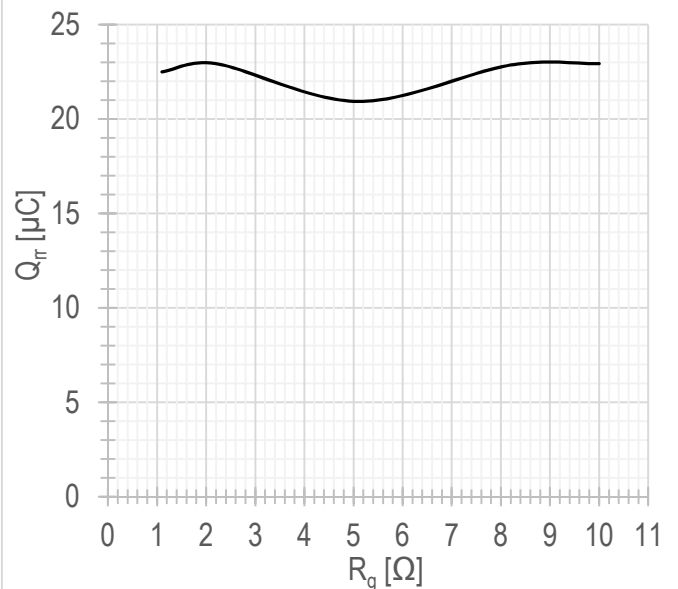
**Chart 8 – RBSOA.**


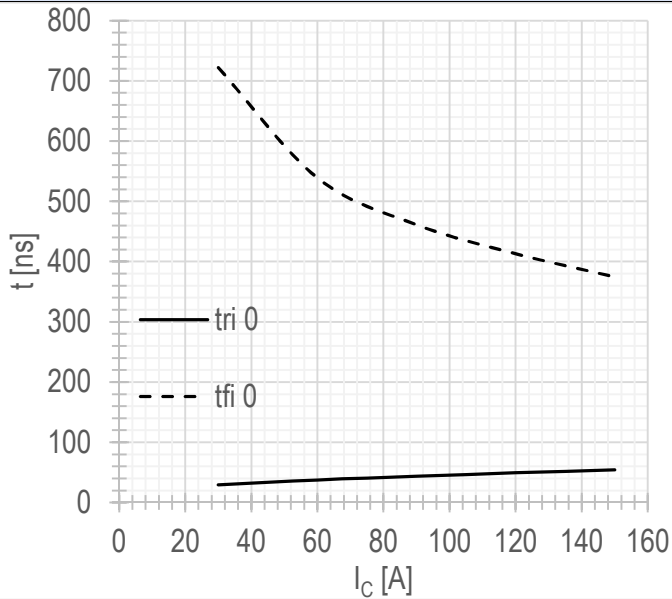
$V_{CEmax} = 1200\text{ V};$   
 $V_{GE} = \pm 15\text{ V};$   
 $I_{Cmax} = 2 \cdot I_{Cnom};$   
 $L = 300\ \mu\text{H}.$

**Chart 9 – typ. output characteristic, FRD.**

 $V_{GE} = +15\text{ V}$ .

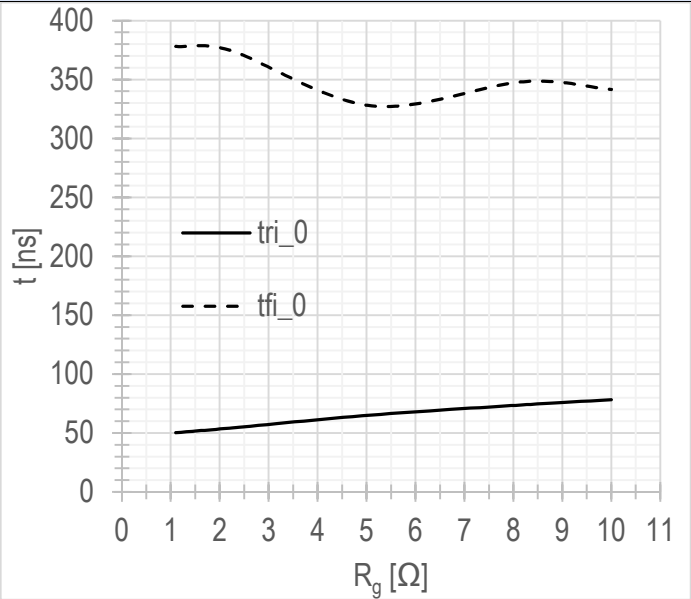
**Chart 10 – typ. swithing losses vs rated current, FRD.**

 $V_{GE} = \pm 15\text{ V}$ ;  
 $V_{CE} = 600\text{ V}$ ;  
 $L = 300\ \mu\text{H}$ ;  
 $R_G = 1.5\ \Omega$ ;  
 $T_{vj(max)} = 150^\circ\text{C}$ .

**Chart 11 – typ. swithing losses vs gate resistanse, FRD.**

 $V_{GE} = \pm 15\text{ V}$ ;  
 $V_{CE} = 600\text{ V}$ ;  
 $I_{Cmax} = 150\text{ A}$ ;  
 $L = 300\ \mu\text{H}$ ;  
 $T_{vj(max)} = 150^\circ\text{C}$ .

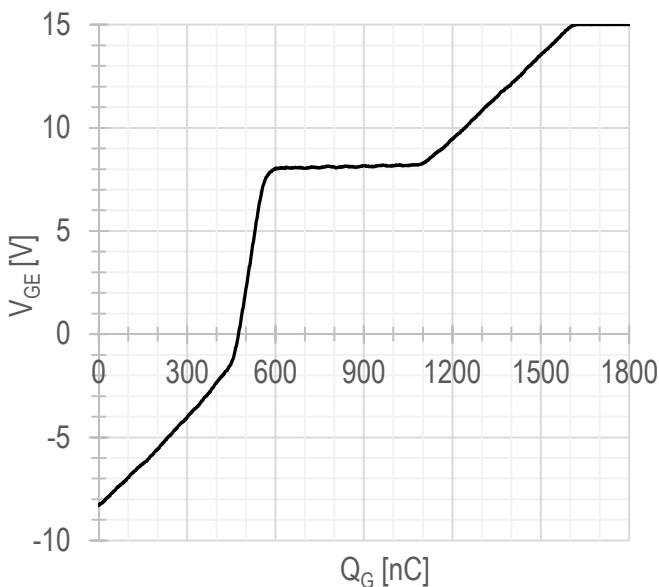
**Chart 12 – typ. reverse recovered charge vs gate resistance, FRD.**

 $V_{GE} = \pm 15\text{ V}$ ;  
 $V_{CE} = 600\text{ V}$ ;  
 $I_{Cmax} = 150\text{ A}$ ;  
 $L = 300\ \mu\text{H}$ ;  
 $T_{vj(max)} = 150^\circ\text{C}$ .

**Chart 13 – typ. switching times vs rated current, FRD.**


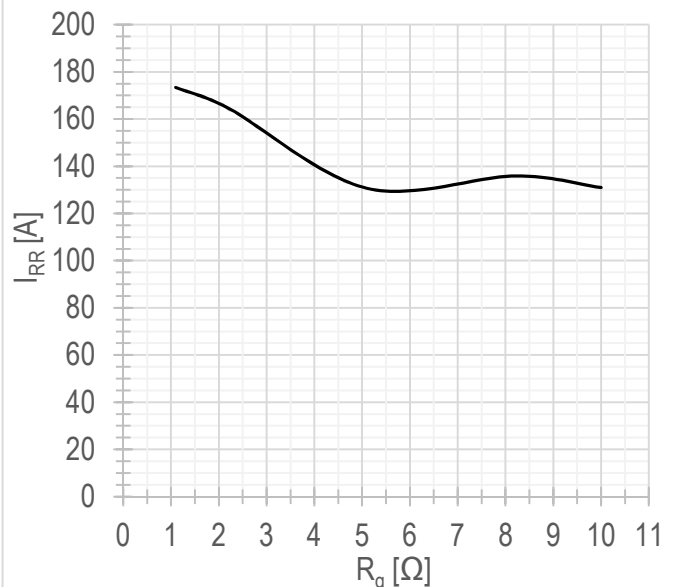
$V_{CE} = 600$  V;  
 $V_{GE} = \pm 15$  V;  
 $R_G = 1.5$   $\Omega$ ;  
 $L = 300$   $\mu$ H.  
 $T_{vj(max)} = 150^\circ$ C.

**Chart 14 – typ. switching times vs gate resistance, FRD.**


$V_{CE} = 600$  V;  
 $V_{GE} = \pm 15$  V;  
 $I_{Cmax} = 150$  A;  
 $L = 300$   $\mu$ H.  
 $T_{vj(max)} = 150^\circ$ C.

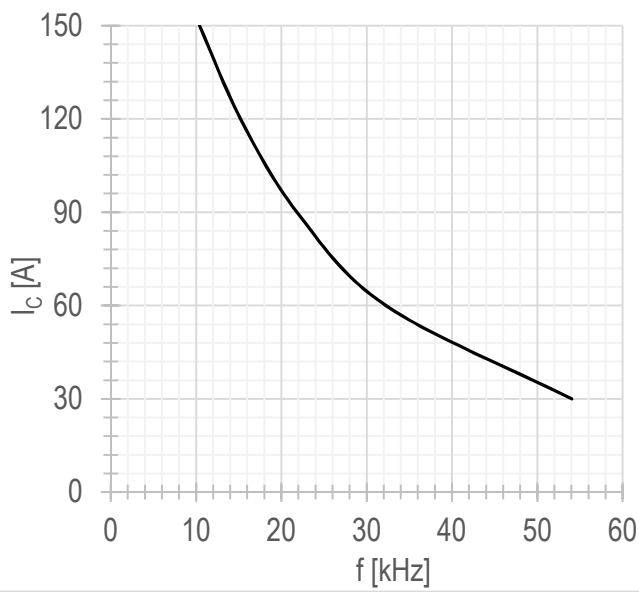
**Chart 15 – typ. gate charge characteristic.**


$I_C = 150$  A;  
 $V_{CE} = 600$  V;  
 $V_{GE} = - 8 \div 15$  V.

**Chart 16 – typ. reverse recovery current vs gate resistance FRD.**


$V_{CE} = 600$  V;  
 $V_{GE} = \pm 15$  V;  
 $L = 300$   $\mu$ H.  
 $T_{vj(max)} = 150^\circ$ C.

Chart 17 – typ. rated current vs frequency.



Duty cycle 50%



